

ZXMD63C03X

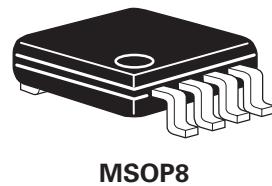
30V DUAL N AND P-CHANNEL ENHANCEMENT MODE MOSFET

SUMMARY

N-CHANNEL: $V_{(BR)DSS}=30V$; $R_{DS(ON)}=0.135\Omega$; $I_D=2.3A$
P-CHANNEL: $V_{(BR)DSS}=-30V$; $R_{DS(ON)}=0.185\Omega$; $I_D=-2.0A$

DESCRIPTION

This new generation of high density MOSFETs from Zetex utilizes a unique structure that combines the benefits of low on-resistance with fast switching speed. This makes them ideal for high efficiency, low voltage, power management applications.



MSOP8

FEATURES

- Low on-resistance
- Fast switching speed
- Low threshold
- Low gate drive
- Low profile SOIC package

APPLICATIONS

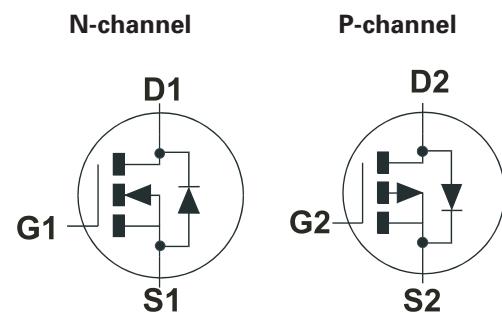
- DC - DC converters
- Power management functions
- Disconnect switches
- Motor control

ORDERING INFORMATION

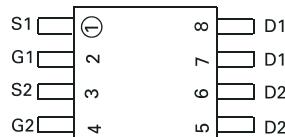
DEVICE	REEL SIZE (inches)	TAPE WIDTH (mm)	QUANTITY PER REEL
ZXMD63C03XTA	7	12 embossed	1,000
ZXMD63C03XTC	13	12 embossed	4,000

DEVICE MARKING

ZXM63C03



Pin-out



Top view

ZXMD63C03X

ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	N-CHANNEL	P-CHANNEL	UNIT
Drain-Source Voltage	V_{DSS}	30	-30	V
Gate- Source Voltage	V_{GS}	± 20		V
Continuous Drain Current ($V_{GS}=4.5V$; $T_A=25^\circ C$)(b)(d) ($V_{GS}=4.5V$; $T_A=70^\circ C$)(b)(d)	I_D	2.3 1.8	-2.0 -1.6	A A
Pulsed Drain Current (c)(d)	I_{DM}	14	-9.6	A
Continuous Source Current (Body Diode)(b)(d)	I_S	1.5	-1.4	A
Pulsed Source Current (Body Diode)(c)(d)	I_{SM}	14	-9.6	A
Power Dissipation at $T_A=25^\circ C$ (a)(d) Linear Derating Factor	P_D	0.87 6.9		W mW/ $^\circ C$
Power Dissipation at $T_A=25^\circ C$ (a)(e) Linear Derating Factor	P_D	1.04 8.3		W mW/ $^\circ C$
Power Dissipation at $T_A=25^\circ C$ (b)(d) Linear Derating Factor	P_D	1.25 10		W mW/ $^\circ C$
Operating and Storage Temperature Range	$T_j:T_{stg}$	-55 to +150		$^\circ C$

THERMAL RESISTANCE

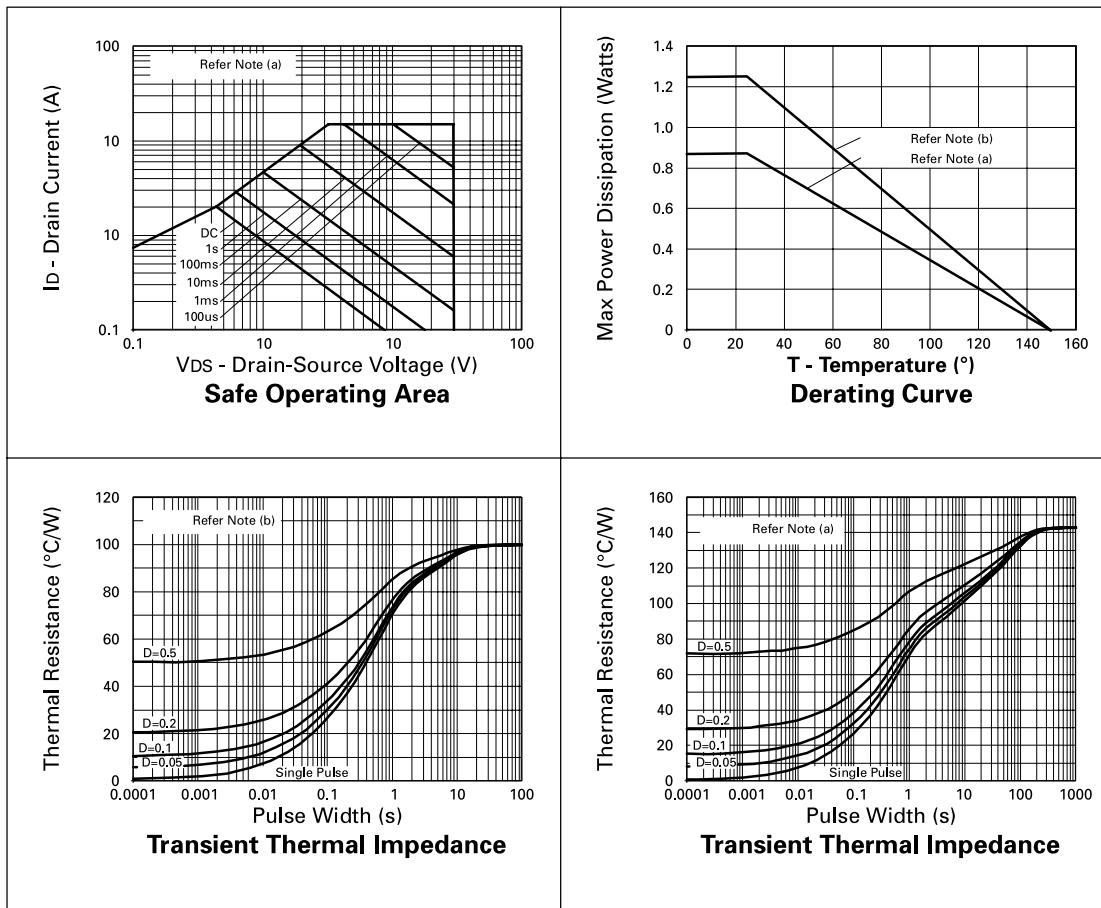
PARAMETER	SYMBOL	VALUE	UNIT
Junction to Ambient (a)(d)	$R_{\theta JA}$	143	$^\circ C/W$
Junction to Ambient (b)(d)	$R_{\theta JA}$	100	$^\circ C/W$
Junction to Ambient (a)(e)	$R_{\theta JA}$	120	$^\circ C/W$

NOTES:

- (a) For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.
- (b) For a device surface mounted on FR4 PCB measured at $t \leq 10$ secs.
- (c) Repetitive rating - pulse width limited by maximum junction temperature. Refer to Transient Thermal Impedance graph.
- (d) For device with one active die.
- (e) For device with two active die running at equal power.

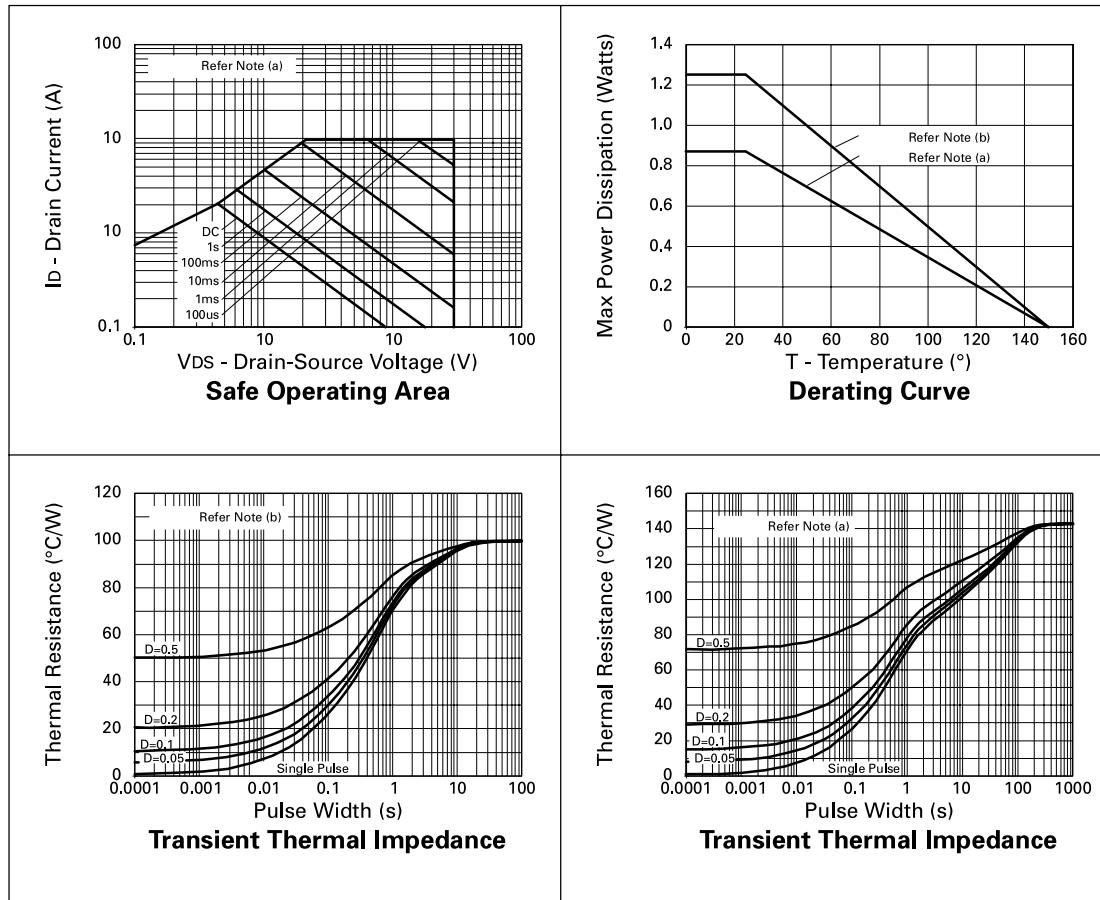
ZXMD63C03X

N-CHANNEL CHARACTERISTICS



ZXMD63C03X

P-CHANNEL CHARACTERISTICS



ZXMD63C03X

**N-CHANNEL
ELECTRICAL CHARACTERISTICS (at $T_{amb} = 25^\circ C$ unless otherwise stated).**

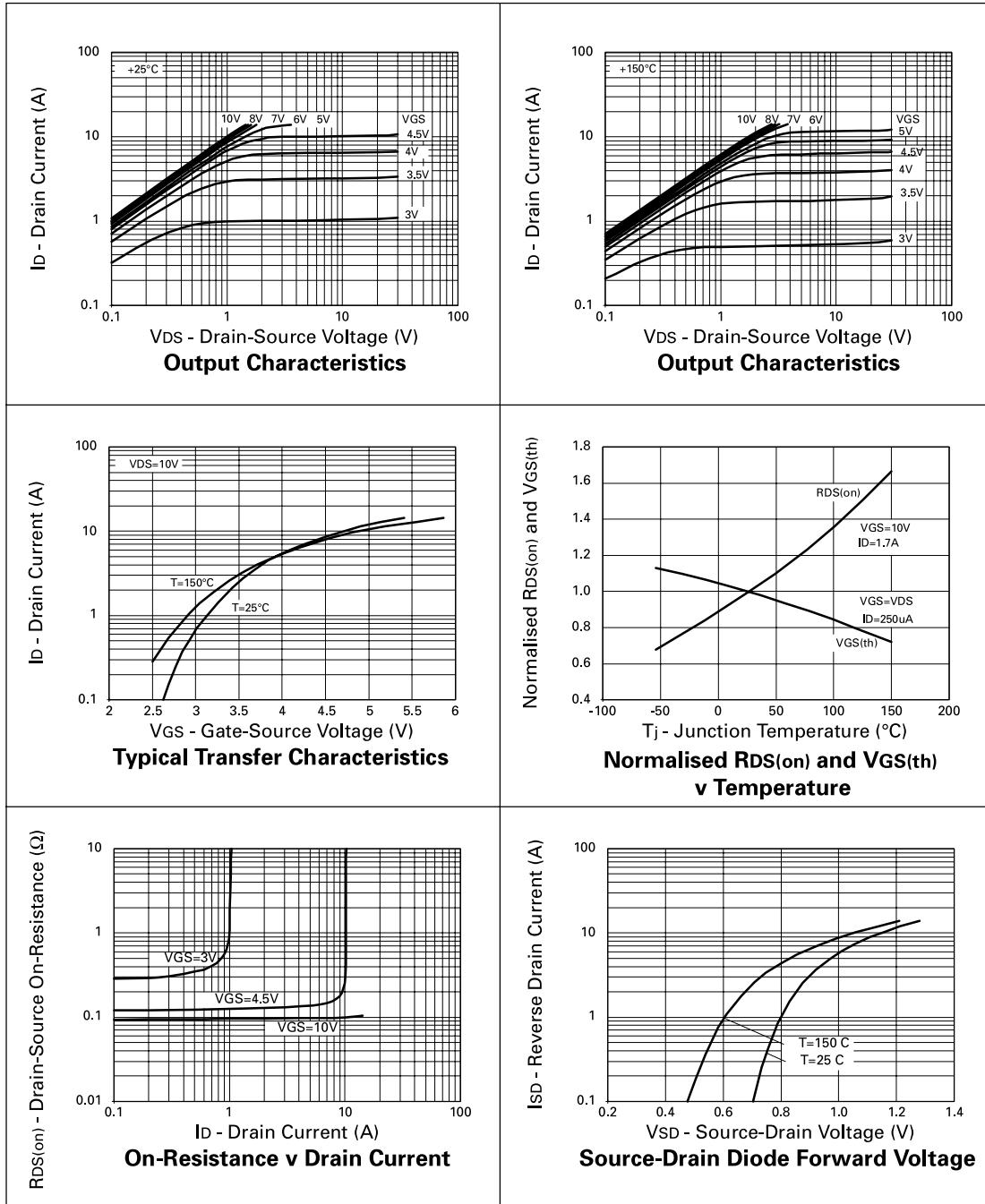
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	CONDITIONS
STATIC						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	30			V	$I_D=250\mu A, V_{GS}=0V$
Zero Gate Voltage Drain Current	I_{DSS}			1	μA	$V_{DS}=30V, V_{GS}=0V$
Gate-Body Leakage	I_{GSS}			100	nA	$V_{GS}=\pm 20V, V_{DS}=0V$
Gate-Source Threshold Voltage	$V_{GS(th)}$	1.0			V	$I_D=250\mu A, V_{DS}=V_{GS}$
Static Drain-Source On-State Resistance (1)	$R_{DS(on)}$			0.135 0.200	Ω	$V_{GS}=10V, I_D=1.7A$ $V_{GS}=4.5V, I_D=0.85A$
Forward Transconductance (3)	g_{fs}	1.9			S	$V_{DS}=10V, I_D=0.85A$
DYNAMIC (3)						
Input Capacitance	C_{iss}		290		pF	$V_{DS}=25V, V_{GS}=0V,$ $f=1MHz$
Output Capacitance	C_{oss}		70		pF	
Reverse Transfer Capacitance	C_{rss}		20		pF	
SWITCHING(2) (3)						
Turn-On Delay Time	$t_{d(on)}$		2.5		ns	$V_{DD}=15V, I_D=1.7A$ $R_G=6.1\Omega, R_D=8.7\Omega$ (Refer to test circuit)
Rise Time	t_r		4.1		ns	
Turn-Off Delay Time	$t_{d(off)}$		9.6		ns	
Fall Time	t_f		4.4		ns	
Total Gate Charge	Q_g			8	nC	$V_{DS}=24V, V_{GS}=10V,$ $I_D=1.7A$ (Refer to test circuit)
Gate-Source Charge	Q_{gs}			1.2	nC	
Gate Drain Charge	Q_{gd}			2	nC	
SOURCE-DRAIN DIODE						
Diode Forward Voltage (1)	V_{SD}			0.95	V	$T_j=25^\circ C, I_S=1.7A,$ $V_{GS}=0V$
Reverse Recovery Time (3)	t_{rr}		16.9		ns	$T_j=25^\circ C, I_F=1.7A,$ $di/dt= 100A/\mu s$
Reverse Recovery Charge(3)	Q_{rr}		9.5		nC	

NOTES:

- (1) Measured under pulsed conditions. Width=300 μs . Duty cycle $\leq 2\%$.
- (2) Switching characteristics are independent of operating junction temperature.
- (3) For design aid only, not subject to production testing.

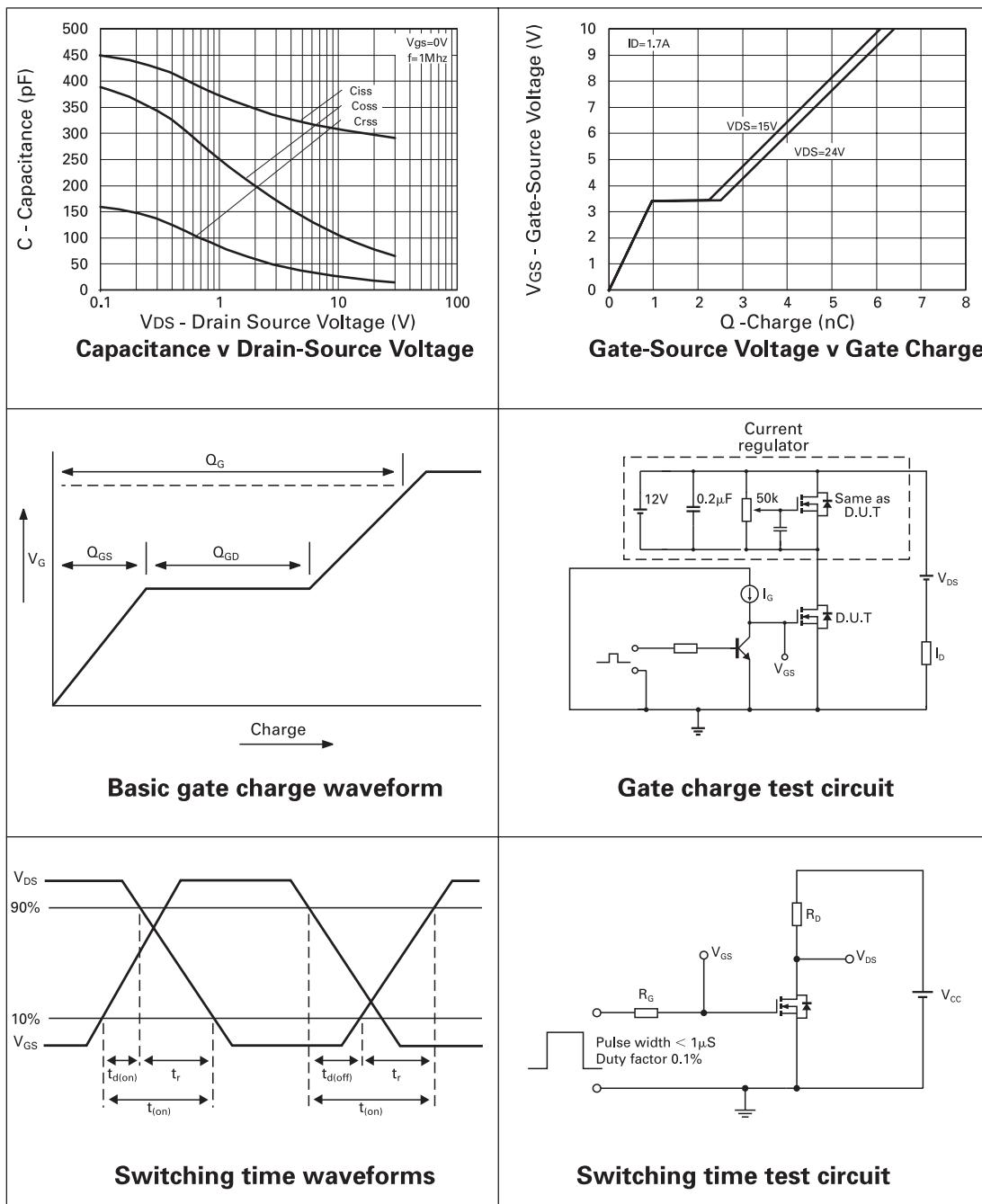
ZXMD63C03X

N-CHANNEL TYPICAL CHARACTERISTICS



ZXMD63C03X

N-CHANNEL CHARACTERISTICS



ZXMD63C03X

**P-CHANNEL
ELECTRICAL CHARACTERISTICS (at $T_{amb} = 25^\circ C$ unless otherwise stated).**

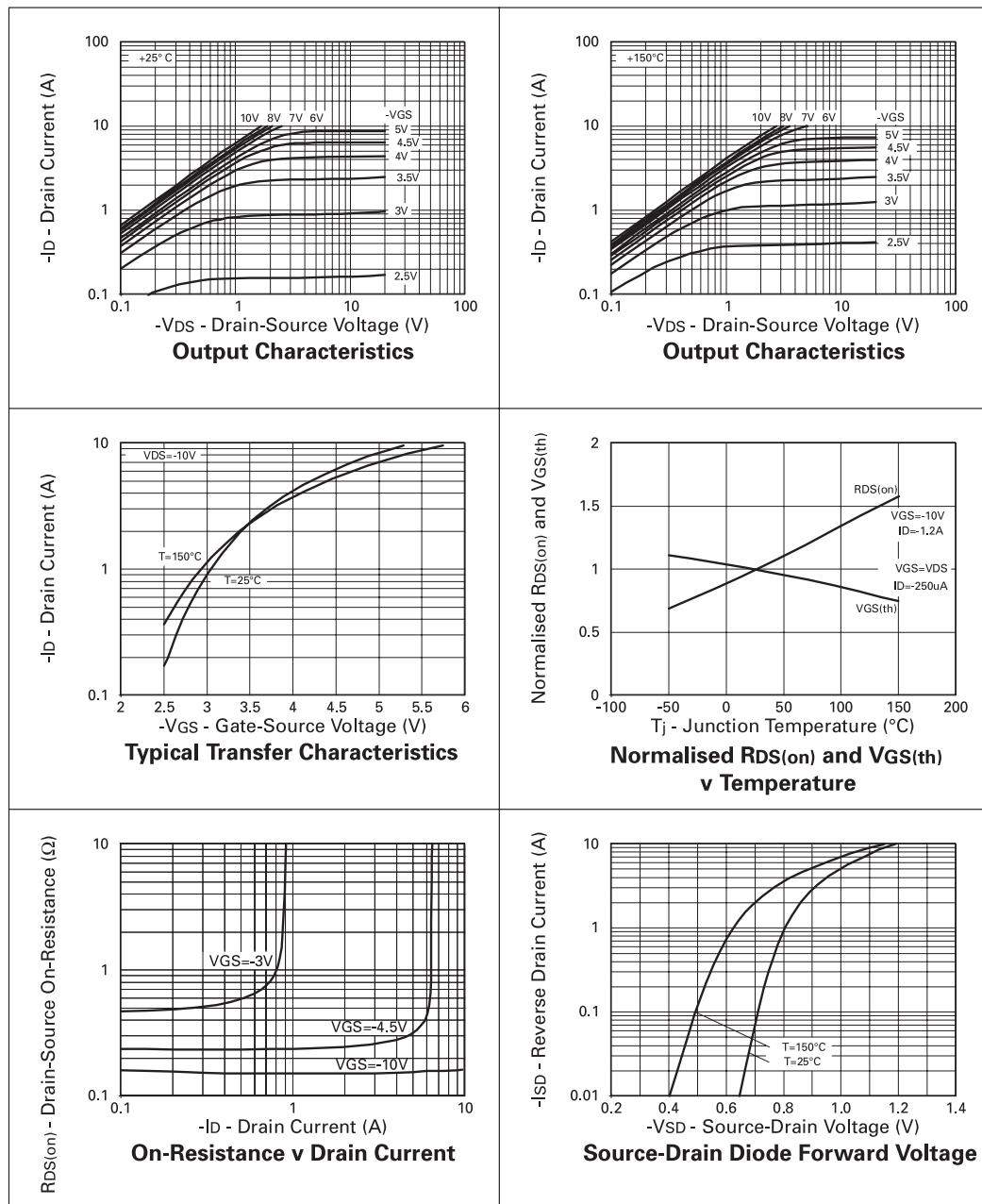
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	CONDITIONS
STATIC						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	-30			V	$I_D=-250\mu A, V_{GS}=0V$
Zero Gate Voltage Drain Current	I_{DSS}			-1	μA	$V_{DS}=-30V, V_{GS}=0V$
Gate-Body Leakage	I_{GSS}			± 100	nA	$V_{GS}=\pm 20V, V_{DS}=0V$
Gate-Source Threshold Voltage	$V_{GS(th)}$	-1.0			V	$I_D=-250\mu A, V_{DS}=V_{GS}$
Static Drain-Source On-State Resistance (1)	$R_{DS(on)}$			0.185 0.27	Ω	$V_{GS}=-10V, I_D=-1.2A$ $V_{GS}=-4.5V, I_D=-0.6A$
Forward Transconductance (3)	g_{fs}	0.92			S	$V_{DS}=-10V, I_D=-0.6A$
DYNAMIC (3)						
Input Capacitance	C_{iss}		270		pF	$V_{DS}=-25 V, V_{GS}=0V,$ $f=1MHz$
Output Capacitance	C_{oss}		80		pF	
Reverse Transfer Capacitance	C_{rss}		30		pF	
SWITCHING(2) (3)						
Turn-On Delay Time	$t_{d(on)}$		2.6		ns	$V_{DD}=-15V, I_D=-1.2A$ $R_G=6.2\Omega, R_D=6.2\Omega$ (Refer to test circuit)
Rise Time	t_r		4.8		ns	
Turn-Off Delay Time	$t_{d(off)}$		13.1		ns	
Fall Time	t_f		9.3		ns	
Total Gate Charge	Q_g			7	nC	$V_{DS}=-24V, V_{GS}=-10V,$ $I_D=-1.2A$ (Refer to test circuit)
Gate-Source Charge	Q_{gs}			1.2	nC	
Gate Drain Charge	Q_{gd}			2	nC	
SOURCE-DRAIN DIODE						
Diode Forward Voltage (1)	V_{SD}			-0.95	V	$T_j=25^\circ C, I_S=-1.2A,$ $V_{GS}=0V$
Reverse Recovery Time (3)	t_{rr}		21.4		ns	$T_j=25^\circ C, I_F=-1.2A,$ $di/dt= 100A/\mu s$
Reverse Recovery Charge(3)	Q_{rr}		15.7		nC	

NOTES:

- (1) Measured under pulsed conditions. Width=300 μs . Duty cycle $\leq 2\%$.
- (2) Switching characteristics are independent of operating junction temperature.
- (3) For design aid only, not subject to production testing.

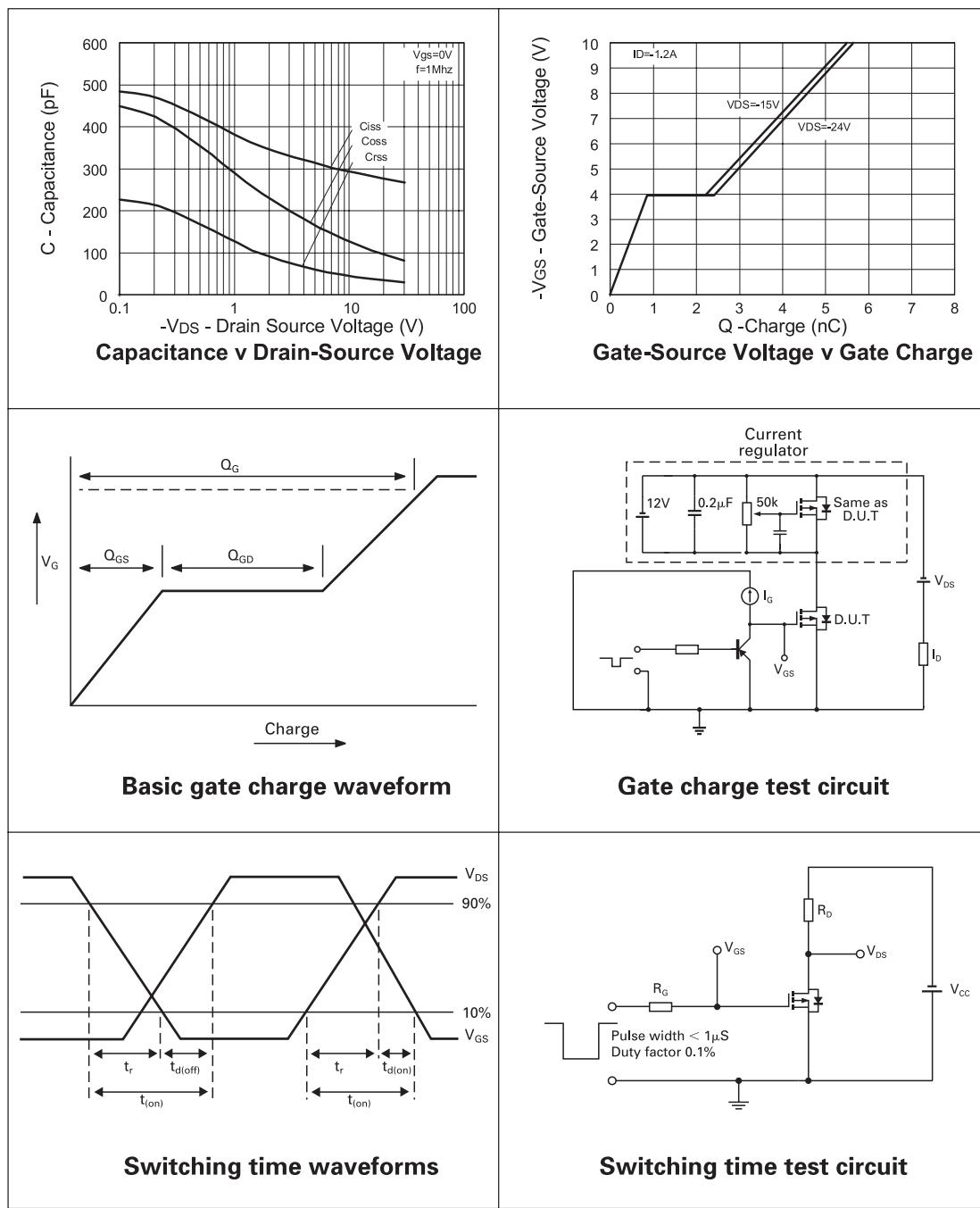
ZXMD63C03X

P-CHANNEL CHARACTERISTICS



ZXMD63C03X

P-CHANNEL TYPICAL CHARACTERISTICS

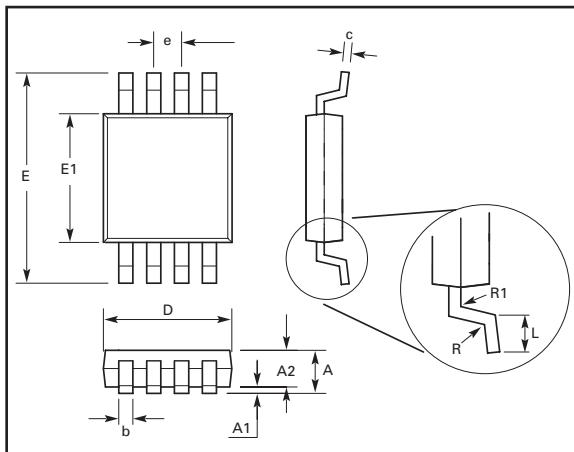


A

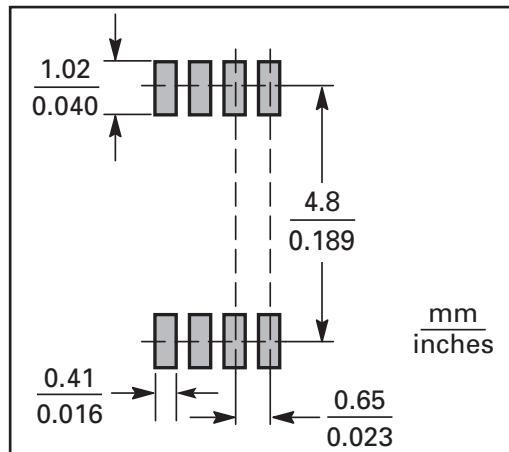
ISSUE 1 - OCTOBER 2005

ZXMD63C03X

PACKAGE DIMENSIONS



PAD LAYOUT DETAILS



DIM	Millimeters		Inches	
	MIN	MAX	MIN	MAX
A	0.91	1.11	0.036	0.044
A1	0.10	0.20	0.004	0.008
B	0.25	0.36	0.010	0.014
C	0.13	0.18	0.005	0.007
D	2.95	3.05	0.116	0.120
e	0.65NOM		0.0256	
e1	0.33NOM		0.0128	
E	2.95	3.05	0.116	0.120
H	4.78	5.03	0.188	0.198
L	0.41	0.66	0.016	0.026
θ°	0°	6°	0°	6°

© Zetex Semiconductors plc 2005

Europe	Americas	Asia Pacific	Corporate Headquarters
Zetex GmbH Streifeldstraße 19 D-81673 München Germany	Zetex Inc 700 Veterans Memorial Hwy Hauppauge, NY 11788 USA	Zetex (Asia) Ltd 3701-04 Metroplaza Tower 1 Hing Fong Road, Kwai Fong Hong Kong	Zetex Semiconductors plc Zetex Technology Park Chadderton, Oldham, OL9 9LL United Kingdom
Telefon: (49) 89 45 49 49 0 Fax: (49) 89 45 49 49 49 europe.sales@zetex.com	Telephone: (1) 631 360 2222 Fax: (1) 631 360 8222 usa.sales@zetex.com	Telephone: (852) 26100 611 Fax: (852) 24250 494 asia.sales@zetex.com	Telephone (44) 161 622 4444 Fax: (44) 161 622 4446 hq@zetex.com

These offices are supported by agents and distributors in major countries world-wide.

This publication is issued to provide outline information only which (unless agreed by the Company in writing) may not be used, applied or reproduced for any purpose or form part of any order or contract or be regarded as a representation relating to the products or services concerned. The Company reserves the right to alter without notice the specification, design, price or conditions of supply of any product or service.

For the latest product information, log on to www.zetex.com

ISSUE 1 - OCTOBER 2005